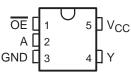
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- EPIC<sup>™</sup> (Enhanced-Performance Implanted CMOS) Process
- Operating Range 2-V to 5.5-V V<sub>CC</sub>
- Package Options Include Plastic Small-Outlline Transistor (DBV, DCK) Packages

## DBV OR DCK PACKAGE (TOP VIEW)



### description

The SN74AHC1G125 is a single bus buffer gate/line driver with 3-state output. The output is disabled when the output-enable  $(\overline{OE})$  input is high. When  $\overline{OE}$  is low, true data is passed from the A input to the Y output.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74AHC1G125 is characterized for operation from -40°C to 85°C.

#### **FUNCTION TABLE**

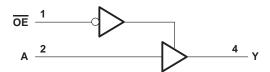
INPU	JTS	OUTPUT
OE	Α	Υ
L	Н	Н
L	L	L
Н	Χ	Z

### logic symbol†



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

### logic diagram (positive logic)





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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	0.5 V to 7 V
Output voltage range, VO (see Note 1)	
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> )	±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±25 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): DBV package	347°C/W
DCK package	389°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions (see Note 3)

			MIN	MAX	UNIT	
VCC	Supply voltage		2	5.5	V	
		V <sub>CC</sub> = 2 V	1.5			
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 3 V	2.1		V	
		V <sub>CC</sub> = 5.5 V	3.85			
		V <sub>CC</sub> = 2 V		0.5		
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 3 V		0.9	V	
		V <sub>CC</sub> = 5.5 V		1.65		
٧ <sub>I</sub>	Input voltage	-	0	5.5	V	
۷o	Output voltage		0	Vcc	V	
		V <sub>CC</sub> = 2 V		-50	μΑ	
loh	High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		-4	A	
		$V_{CC} = 5 V \pm 0.5 V$		-8	mA	
		V <sub>CC</sub> = 2 V		50	μΑ	
loL	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		4	A	
		$V_{CC} = 5 V \pm 0.5 V$		8	mA	
A+/A>.	langet transition rice or fall rate	V <sub>CC</sub> = 3.3 V ± 0.3 V		100	0 ns/V	
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 5 V \pm 0.5 V$		20	HS/V	
T <sub>A</sub>	Operating free-air temperature	-	-40	85	°C	

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51.

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Voc	T,	ղ = 25°C	;	MIN MAX	MAX	UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	IVIIIV	WAX	UNIT
	I <sub>OH</sub> = -50 μA	2 V	1.9	2		1.9		
		3 V	2.9	3		2.9		
Voн		4.5 V	4.4	4.5		4.4		V
	I <sub>OH</sub> = -4 mA	3 V	2.58			2.48		
	I <sub>OH</sub> = -8 mA	4.5 V	3.94			3.8		
		2 V			0.1		0.1	V
	I <sub>OL</sub> = 50 μA	3 V			0.1		0.1	
V <sub>OL</sub>		4.5 V			0.1		0.1	
		3 V			0.36		0.44	
	I <sub>OL</sub> = 8 mA	4.5 V			0.36		0.44	
lį	$V_I = V_{CC}$ or GND	0 V to 5.5 V			±0.1		±1	μΑ
loz	$V_I = V_{CC}$ or GND	5.5 V			±0.25		±2.5	μА
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			1		10	μΑ
Ci	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		4	10		10	pF
Co	V <sub>O</sub> = V <sub>CC</sub> or GND	5 V		10				pF

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1)

DADAMETED	ARAMETER FROM TO LOAD		T <sub>A</sub> = 2	5°C	MIN	MAX	UNIT																				
PARAWETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN TY	P MAX	IVIIIN	IVIAA	UNIT																			
<sup>t</sup> PLH		Y	C <sub>L</sub> = 15 pF	5	6 8	1	9.5	ns																			
<sup>t</sup> PHL	А	ι ομ - 13 μι	5	6 8	1	9.5	115																				
<sup>t</sup> PZH	<u>OE</u>	Y	C <sub>L</sub> = 15 pF	5	4 8	1	9.5	ns																			
t <sub>PZL</sub>	] 05	CL = 15 pr		5	4 8	1	9.5	115																			
<sup>t</sup> PHZ	ŌĒ	Y	Y C <sub>L</sub> = 15 pF		7 9.7	1	11.5	ns																			
<sup>t</sup> PLZ	OE			1	1	ı	ı	1	'	,	,	1	ı	·	ı	1	·	·	1	'	·	•	. 0[-10	OL = 13 pr		7 9.7	1
t <sub>PLH</sub>	A	Y	C: - 50 pE	8	1 11.5	1	13	ns																			
<sup>t</sup> PHL	A	l I	T	'		T T	T	1	<u> </u>				T T	<b>1</b>	ľ	l '	Ť	Y $C_L = 50 \text{ pF}$	OL = 30 pr	8	1 11.5	1	13	115			
<sup>t</sup> PZH	ŌĒ	Y	C <sub>L</sub> = 50 pF	7	9 11.5	1	13	ns																			
tPZL	OE	l '	T T	·   '	CL = 50 pr	7	9 11.5	1	13	110																	
<sup>t</sup> PHZ	ŌĒ	V	C <sub>L</sub> = 50 pF	9	5 13.2	1	15	no																			
t <sub>PLZ</sub>	OE .	Y	CL = 50 pr	9	5 13.2	1	15	ns																			

### SN74AHC1G125 SINGLE BUS BUFFER GATE WITH 3-STATE OUTPUT

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# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

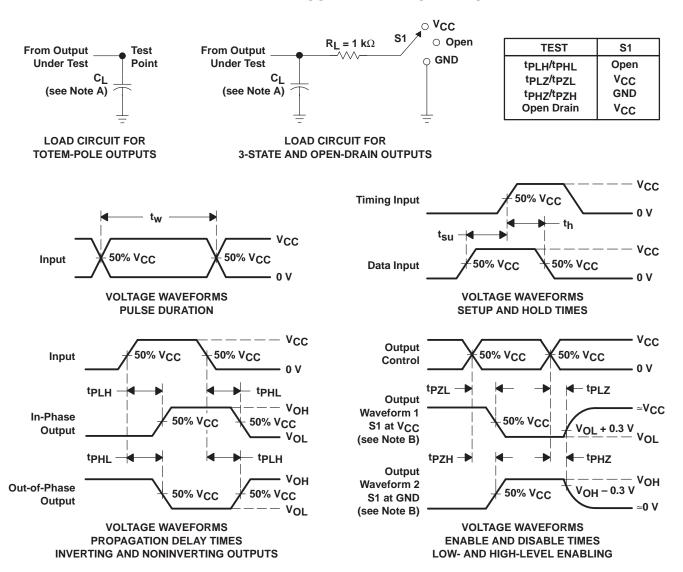
PARAMETER	FROM	то	LOAD	T,	չ = 25°C	;	MIN	MAX	UNIT																	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	IVIIIN	WIIIN WAA	UNIT																	
<sup>t</sup> PLH	А	Y	C <sub>I</sub> = 15 pF		3.8	5.5	1	6.5	ns																	
t <sub>PHL</sub>	^		OL = 13 bi		3.8	5.5	1	6.5	115																	
<sup>t</sup> PZH	ŌĒ	Y	C <sub>L</sub> = 15 pF		3.6	5.1	1	6	ns																	
<sup>t</sup> PZL	OE		Y CL = 15 pF		3.6	5.1	1	6	115																	
<sup>t</sup> PHZ	ŌĒ	Y	Y C <sub>l</sub>	Y C <sub>L</sub> = 15 pF	C: _ 15 pE		4.6	6.8	1	8	ns															
<sup>t</sup> PLZ	OE				ſ		ı	ľ	1	ľ	ľ		ı	ı	ı	ı	ı	ı	ı	ı	'	, J	OL = 15 pr		4.6	6.8
<sup>t</sup> PLH	А	Y	C <sub>L</sub> = 50 pF		5.3	7.5	1	8.5	ns																	
<sup>t</sup> PHL	A		CL = 50 pr		5.3	7.5	1	8.5	115																	
<sup>t</sup> PZH	ŌĒ	Y	C <sub>L</sub> = 50 pF		5.1	7.1	1	8	no																	
<sup>t</sup> PZL	OE		ſ	T		'	'		CL = 50 pr		5.1	7.1	1	8	ns											
<sup>t</sup> PHZ	ŌĒ	Y	V	V	OF V C 50	C: - 50 pE		6.1	8.8	1	10	nc														
t <sub>PLZ</sub>	] 05		C <sub>L</sub> = 50 pF		6.1	8.8	1	10	ns																	

## operating characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

	PARAMETER	FARAMETER   TEST CONDITIONS   T		TYP	UNIT
С	od Power dissipation capacitance	No load,	f = 1 MHz	14	pF



#### PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 3$  ns,  $t_f \leq 3$  ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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